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Applications of "Embedded - Microcontrollers"

Details	
Product Status	Last Time Buy
Core Processor	ARM® Cortex®-M0
Core Size	32-Bit Single-Core
Speed	50MHz
Connectivity	EBI/EMI, I²C, IrDA, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, I²S, LVD, POR, PS2, PWM, WDT
Number of I/O	49
Program Memory Size	32KB (32K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	2.5V ~ 5.5V
Data Converters	A/D 8x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/nuvoton-technology-corporation-america/nuc100rc1bn

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2 FEATURES

The equipped features are dependent on the product line and their sub products.

2.1 NuMicro™ NUC100 Features – Advanced Line

- Core
  - ARM® Cortex™-M0 core runs up to 50 MHz
  - One 24-bit system timer
  - Supports low power sleep mode
  - Single-cycle 32-bit hardware multiplier
  - NVIC for the 32 interrupt inputs, each with 4-levels of priority
  - Serial Wire Debug supports with 2 watchpoints/4 breakpoints
- Build-in LDO for wide operating voltage ranges from 2.5 V to 5.5 V
- Flash Memory
  - 32K/64K/128K bytes Flash for program code (128KB only support in NuMicro™ NUC100/NUC120 Medium Density)
  - 4KB flash for ISP loader
  - Support In-system program (ISP) application code update
  - 512 byte page erase for flash
  - Configurable data flash address and size for 128KB system, fixed 4KB data flash for the 32KB and 64KB system
  - Support 2 wire ICP update through SWD/ICE interface
  - Support fast parallel programming mode by external programmer
- SRAM Memory
  - 4K/8K/16K bytes embedded SRAM (16KB only support in NuMicro™ NUC100/NUC120 Medium Density)
  - Support PDMA mode
- PDMA (Peripheral DMA)
  - Support 9 channels PDMA for automatic data transfer between SRAM and peripherals (Only support 1 channel in NuMicro™ NUC100/NUC120 Low Density)
- Clock Control
  - Flexible selection for different applications
  - Built-in 22.1184 MHz high speed OSC for system operation
    - Trimmed to ± 1 % at +25 ℃ and V_{DD} = 5 V
    - Trimmed to ± 3 % at -40 ℃ ~ +85 ℃ and V_{DD} = 2.5 V ~ 5.5 V
  - Built-in 10 kHz low speed OSC for Watchdog Timer and Wake-up operation
  - Support one PLL, up to 50 MHz, for high performance system operation
  - External 4~24 MHz high speed crystal input for precise timing operation
  - External 32.768 kHz low speed crystal input for RTC function and low power system operation
- GPIO
  - Four I/O modes:
    - Quasi bi-direction
    - Push-Pull output
    - Open-Drain output
    - Input only with high impendence

3 PARTS INFORMATION LIST AND PIN CONFIGURATION

3.1 NuMicro™ NUC100 Products Selection Guide

3.1.1 NuMicro™ NUC100 Medium Density Advance Line Selection Guide

Part number	APROM	RAM	Data Flash	ISP Loader ROM	I/O	Timer	Connectivity						I^2S	Comp.	PWM	ADC	RTC	EBI	ISP ICP	Package
							UART	SPI	I^2C	USB	LIN	CAN								
NUC100LD3AN	64 KB	16 KB	4 KB	4 KB	up to 35	4x32-bit	2	1	2	-	-	-	1	1	6	8x12-bit	v	-	v	LQFP48
NUC100LE3AN	128 KB	16 KB	Definable	4 KB	up to 35	4x32-bit	2	1	2	-	-	-	1	1	6	8x12-bit	v	-	v	LQFP48
NUC100RD3AN	64 KB	16 KB	4 KB	4 KB	up to 49	4x32-bit	3	2	2	-	-	-	1	2	6	8x12-bit	v	-	v	LQFP64
NUC100RE3AN	128 KB	16 KB	Definable	4 KB	up to 49	4x32-bit	3	2	2	-	-	-	1	2	6	8x12-bit	v	-	v	LQFP64
NUC100VD2AN	64 KB	8 KB	4 KB	4 KB	up to 80	4x32-bit	3	4	2	-	-	-	1	2	8	8x12-bit	v	-	v	LQFP100
NUC100VD3AN	64 KB	16 KB	4 KB	4 KB	up to 80	4x32-bit	3	4	2	-	-	-	1	2	8	8x12-bit	v	-	v	LQFP100
NUC100VE3AN	128 KB	16 KB	Definable	4 KB	up to 80	4x32-bit	3	4	2	-	-	-	1	2	8	8x12-bit	v	-	v	LQFP100

3.1.2 NuMicro™ NUC100 Low Density Advance Line Selection Guide

Part number	APROM	RAM	Data Flash	ISP Loader ROM	I/O	Timer	Connectivity						I^2S	Comp.	PWM	ADC	RTC	EBI	ISP ICP	Package
							UART	SPI	I^2C	USB	LIN	CAN								
NUC100LC1BN	32 KB	4 KB	4 KB	4 KB	up to 35	4x32-bit	2	1	2	-	-	-	1	1	4	8x12-bit	v	-	v	LQFP48
NUC100LD1BN	64 KB	4 KB	4 KB	4 KB	up to 35	4x32-bit	2	1	2	-	-	-	1	1	4	8x12-bit	v	-	v	LQFP48
NUC100LD2BN	64 KB	8 KB	4 KB	4 KB	up to 35	4x32-bit	2	1	2	-	-	-	1	1	4	8x12-bit	v	-	v	LQFP48
NUC100RC1BN	32 KB	4 KB	4 KB	4 KB	up to 49	4x32-bit	2	2	2	-	-	-	1	2	4	8x12-bit	v	v	v	LQFP64
NUC100RD1BN	64 KB	4 KB	4 KB	4 KB	up to 49	4x32-bit	2	2	2	-	-	-	1	2	4	8x12-bit	v	v	v	LQFP64
NUC100RD2BN	64 KB	8 KB	4 KB	4 KB	up to 49	4x32-bit	2	2	2	-	-	-	1	2	4	8x12-bit	v	v	v	LQFP64

3.2.2 NuMicro™ NUC100 Low Density Pin Diagram

3.2.2.1 NuMicro™ NUC100 Low Density LQFP 64 pin

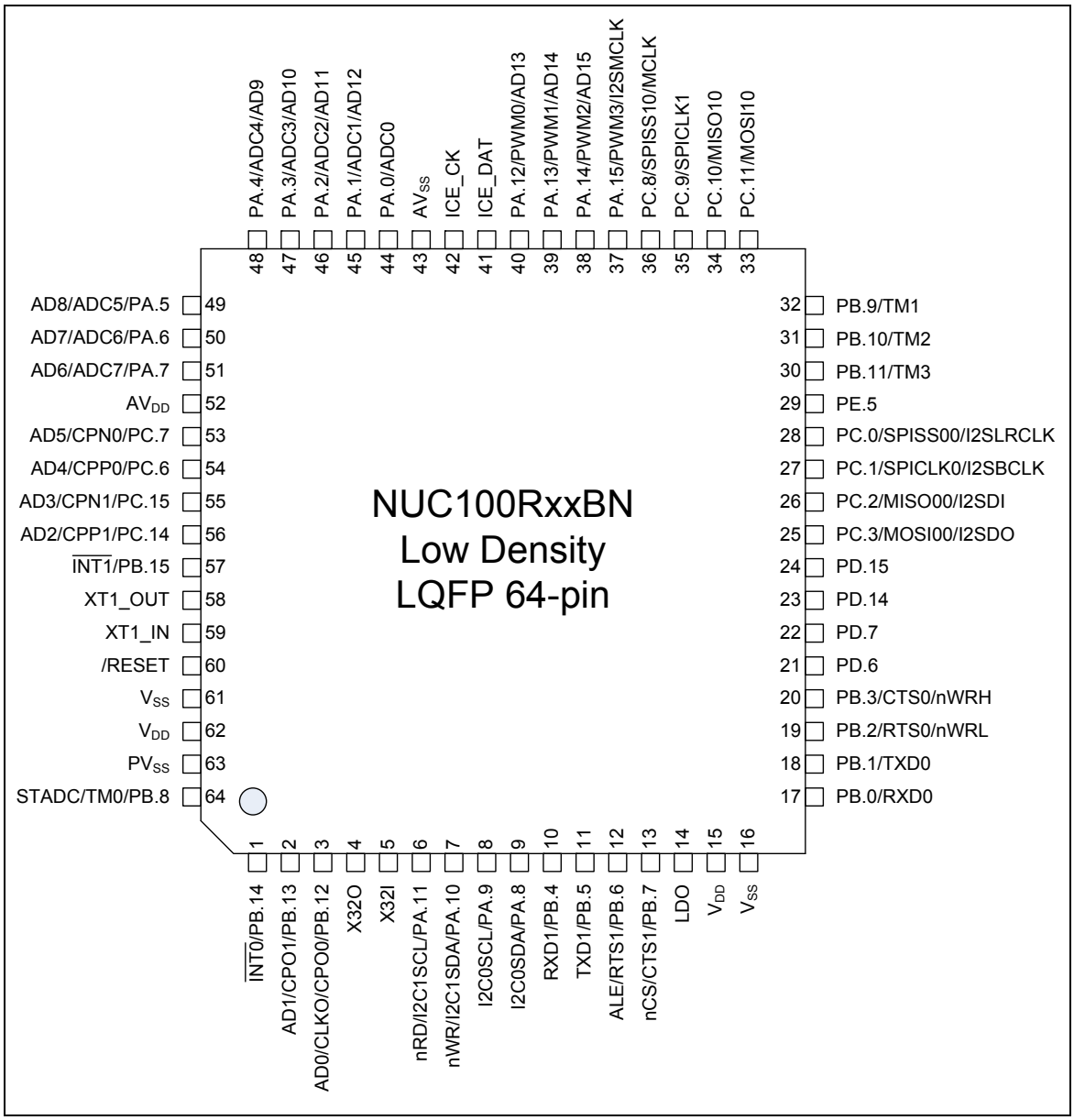


Figure 3-4 NuMicro™ NUC100 Low Density LQFP 64-pin Pin Diagram

Address Space	Token	Controllers
0x400E_0000 – 0x400E_FFFF	ADC_BA	Analog-Digital-Converter (ADC) Control Registers
APB2 Controllers Space (0x4010_0000 ~ 0x401F_FFFF)		
0x4010_0000 – 0x4010_3FFF	PS2_BA	PS/2 Interface Control Registers
0x4011_0000 – 0x4011_3FFF	TMR23_BA	Timer2/Timer3 Control Registers
0x4012_0000 – 0x4012_3FFF	I2C1_BA	I^2C1 Interface Control Registers
0x4013_0000 – 0x4013_3FFF	SPI2_BA	SPI2 with master/slave function Control Registers (NuMicro™ NUC100/NUC120 Medium Density Only)
0x4013_4000 – 0x4013_7FFF	SPI3_BA	SPI3 with master/slave function Control Registers (NuMicro™ NUC100/NUC120 Medium Density Only)
0x4014_0000 – 0x4014_3FFF	PWMB_BA	PWM4/5/6/7 Control Registers (NuMicro™ NUC100/NUC120 Medium Density Only)
0x4015_0000 – 0x4015_3FFF	UART1_BA	UART1 Control Registers
0x4015_4000 – 0x4015_7FFF	UART2_BA	UART2 Control Registers (NuMicro™ NUC100/NUC120 Medium Density Only)
0x401A_0000 – 0x401A_3FFF	I2S_BA	I^2S Interface Control Registers
System Controllers Space (0xE000_E000 ~ 0xE000_EFFF)		
0xE000_E010 – 0xE000_E0FF	SCS_BA	System Timer Control Registers
0xE000_E100 – 0xE000_ECFF	SCS_BA	External Interrupt Controller Control Registers
0xE000_ED00 – 0xE000_ED8F	SCS_BA	System Control Registers

Table 5-1 Address Space Assignments for On-Chip Controllers

Vector Number	Interrupt Number (Bit in Interrupt Registers)	Interrupt Name	Source IP	Interrupt description
26	10	**TMR2_INT**	TMR2	Timer 2 interrupt
27	11	**TMR3_INT**	TMR3	Timer 3 interrupt
28	12	**UART02_INT**	UART0/2	UART0 and UART2 interrupt
29	13	**UART1_INT**	UART1	UART1 interrupt
30	14	**SPI0_INT**	SPI0	SPI0 interrupt
31	15	**SPI1_INT**	SPI1	SPI1 interrupt
32	16	**SPI2_INT**	SPI2	SPI2 interrupt
33	17	**SPI3_INT**	SPI3	SPI3 interrupt
34	18	**I2C0_INT**	I^2C0	I^2C0 interrupt
35	19	**I2C1_INT**	I^2C1	I^2C1 interrupt
36	20	**Reserved**	Reserved	Reserved
37	21	**Reserved**	Reserved	Reserved
38	22	**Reserved**	Reserved	Reserved
39	23	**USB_INT**	USBD	USB 2.0 FS Device interrupt
40	24	**PS2_INT**	PS/2	PS/2 interrupt
41	25	**ACMP_INT**	ACMP	Analog Comparator-0 or Comaprator-1 interrupt
42	26	**PDMA_INT**	PDMA	PDMA interrupt
43	27	**I2S_INT**	I^2S	I^2S interrupt
44	28	**PWRWU_INT**	CLKC	Clock controller interrupt for chip wake-up from power down state
45	29	**ADC_INT**	ADC	ADC interrupt
46	30	**Reserved**	Reserved	Reserved
47	31	**RTC_INT**	RTC	Real time clock interrupt

Table 5-3 System Interrupt Map

5.2.6.2 Vector Table

When any interrupts is accepted, the processor will automatically fetch the starting address of the interrupt service routine (ISR) from a vector table in memory. For ARMv6-M, the vector table base address is fixed at 0x00000000. The vector table contains the initialization value for the stack pointer on reset, and the entry point addresses for all exception handlers. The vector number on previous page defines the order of entries in the vector table associated with exception handler entry as illustrated in previous section.

Vector Table Word Offset	Description
0	SP_main – The Main stack pointer
Vector Number	Exception Entry Pointer using that Vector Number

Table 5-4 Vector Table Format

5.2.6.3 Operation Description

NVIC interrupts can be enabled and disabled by writing to their corresponding Interrupt Set-Enable or Interrupt Clear-Enable register bit-field. The registers use a write-1-to-enable and write-1-to-clear policy, both registers reading back the current enabled state of the corresponding interrupts. When an interrupt is disabled, interrupt assertion will cause the interrupt to become Pending, however, the interrupt will not activate. If an interrupt is Active when it is disabled, it remains in its Active state until cleared by reset or an exception return. Clearing the enable bit prevents new activations of the associated interrupt.

NVIC interrupts can be pended/un-pended using a complementary pair of registers to those used to enable/disable the interrupts, named the Set-Pending Register and Clear-Pending Register respectively. The registers use a write-1-to-enable and write-1-to-clear policy, both registers reading back the current pended state of the corresponding interrupts. The Clear-Pending Register has no effect on the execution status of an Active interrupt.

NVIC interrupts are prioritized by updating an 8-bit field within a 32-bit register (each register supporting four interrupts).

The general registers associated with the NVIC are all accessible from a block of memory in the System Control Space and will be described in next section.

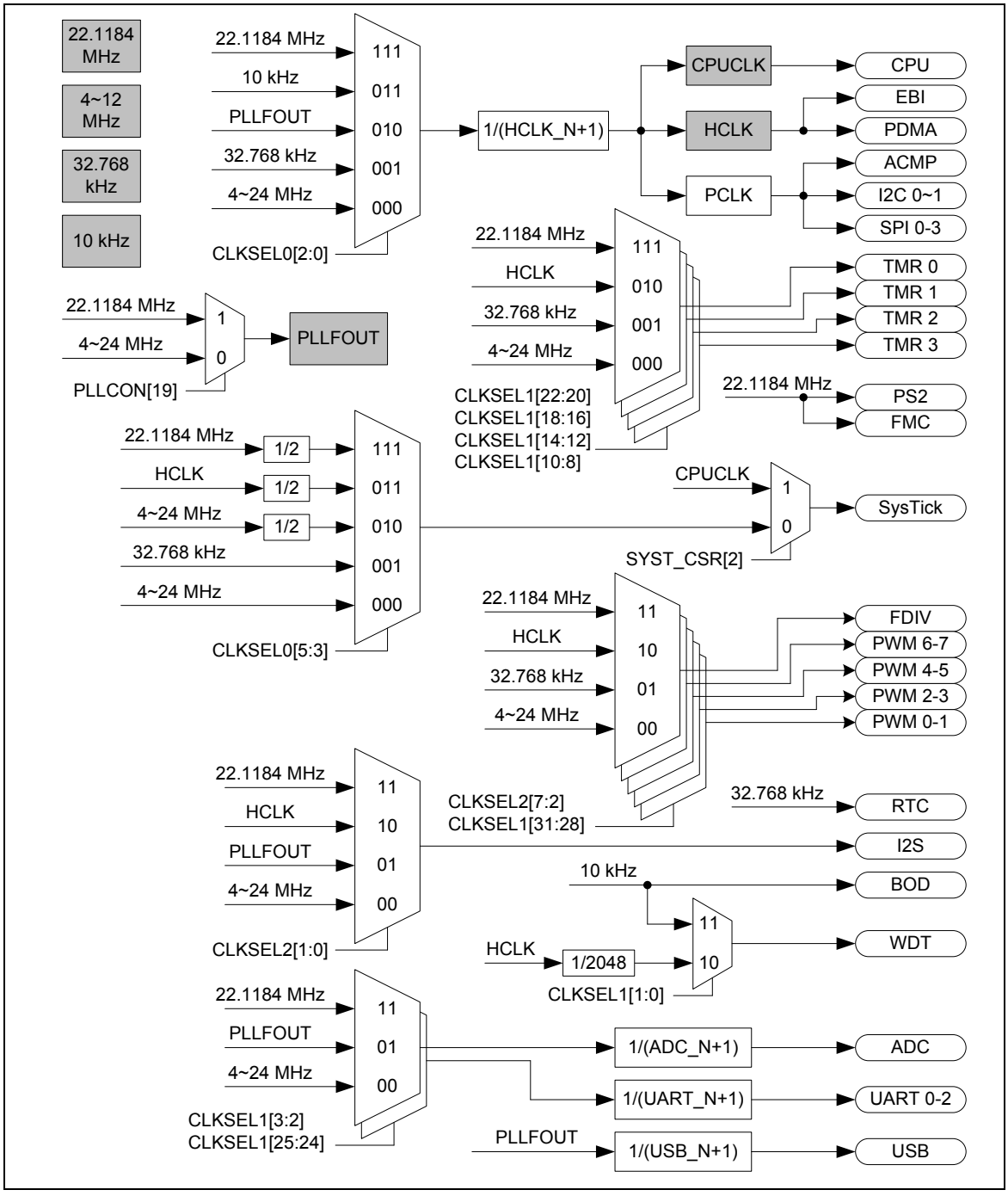


Figure 5-3 Clock generator global view diagram

5.3.2 Clock Generator

The clock generator consists of 5 clock sources which are listed below:

- One external 32.768 kHz low speed crystal
- One external 4~24 MHz high speed crystal
- One programmable PLL FOUT(PLL source consists of external 4~24 MHz high speed crystal and internal 22.1184 MHz high speed oscillator)
- One internal 22.1184 MHz high speed oscillator
- One internal 10 kHz low speed oscillator

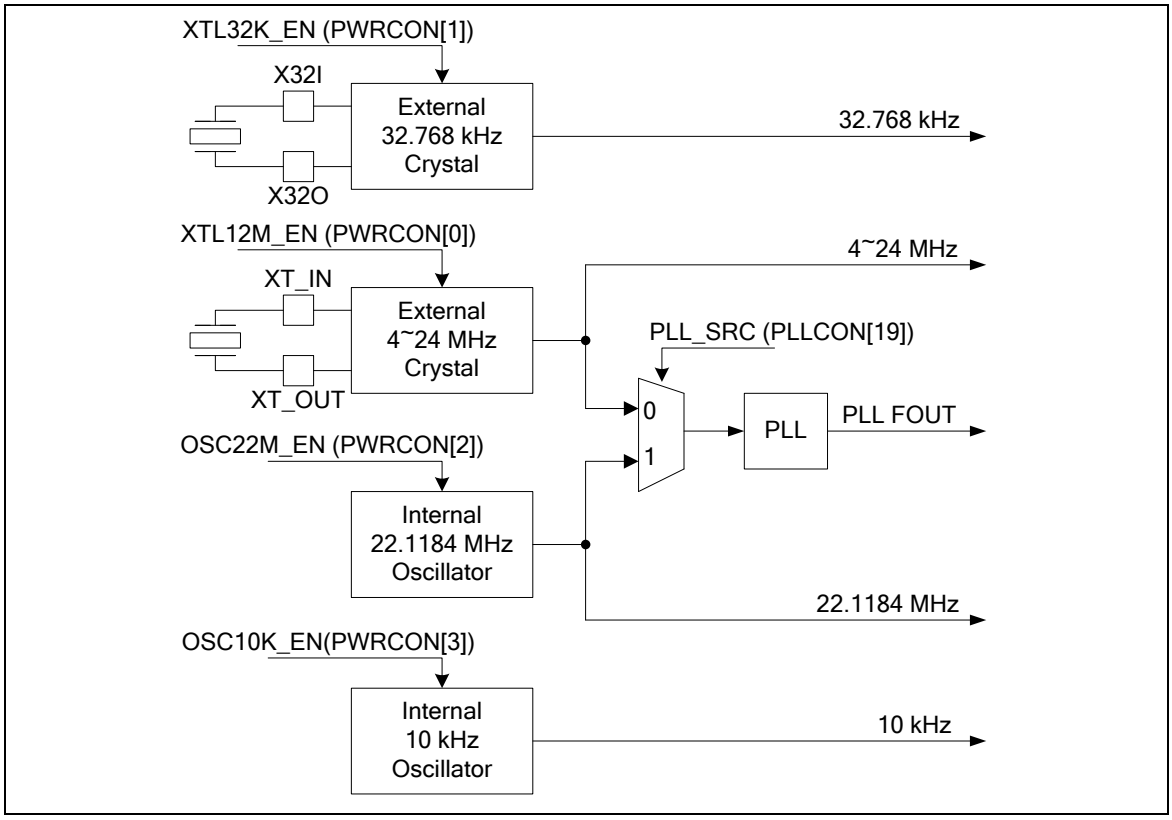


Figure 5-4 Clock generator block diagram

5.3.3 System Clock and SysTick Clock

The system clock has 5 clock sources which were generated from clock generator block. The clock source switch depends on the register HCLK_S (CLKSEL0[2:0]). The block diagram is showed in Figure 5-5.

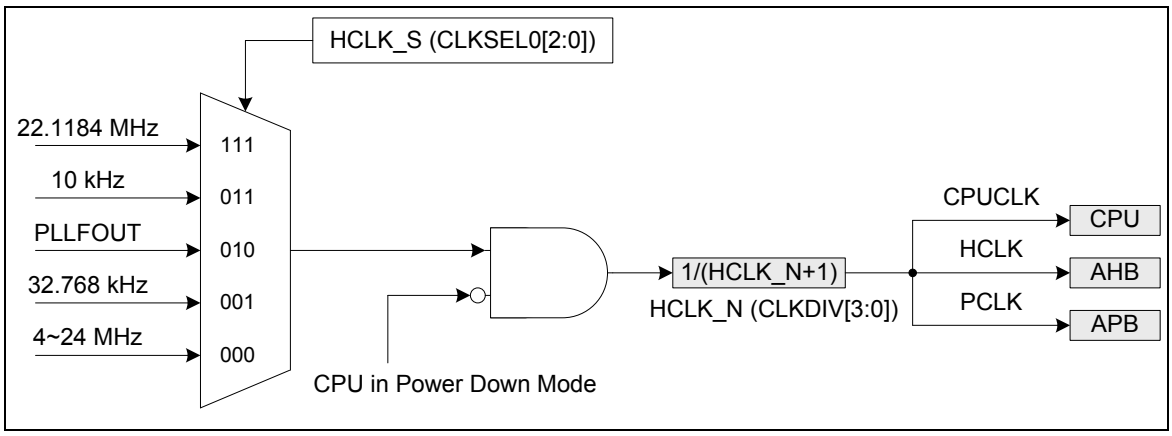


Figure 5-5 System Clock Block Diagram

The clock source of SysTick in Cortex-M0 core can use CPU clock or external clock (SYST_CSR[2]). If using external clock, the SysTick clock (STCLK) has 5 clock sources. The clock source switch depends on the setting of the register STCLK_S (CLKSEL0[5:3]). The block diagram is showed in Figure 5-6.

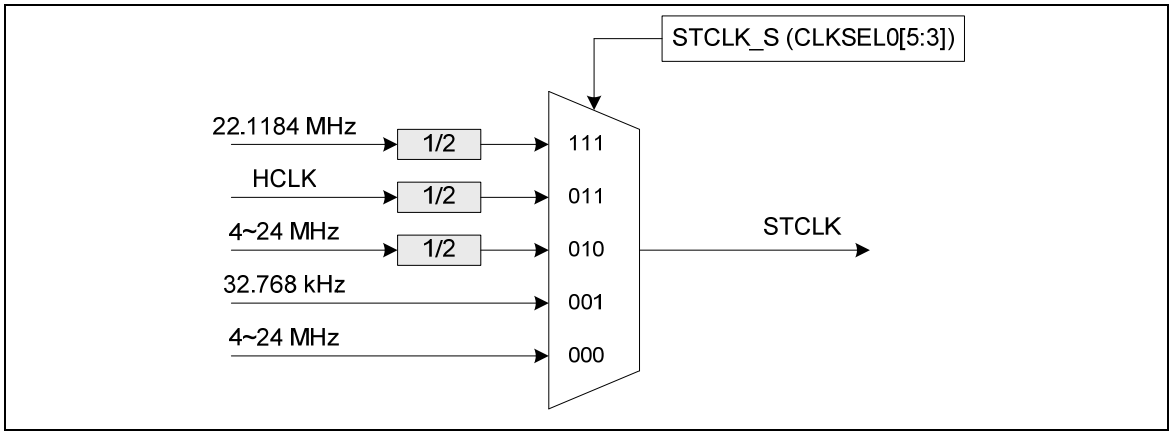


Figure 5-6 SysTick Clock Control Block Diagram

5.5.2 Features

The I²C bus uses two wires (SDA and SCL) to transfer information between devices connected to the bus. The main features of the bus are:

- Master/Slave mode
- Bidirectional data transfer between masters and slaves
- Multi-master bus (no central master)
- Arbitration between simultaneously transmitting masters without corruption of serial data on the bus
- Serial clock synchronization allows devices with different bit rates to communicate via one serial bus
- Serial clock synchronization can be used as a handshake mechanism to suspend and resume serial transfer
- Built-in a 14-bit time-out counter will request the I²C interrupt if the I²C bus hangs up and timer-out counter overflows.
- External pull-up are needed for high output
- Programmable clocks allow versatile rate control
- Supports 7-bit addressing mode
- I²C-bus controllers support multiple address recognition (Four slave address with mask option)

the PWM counter 0/1/2/3 will be reload at this moment.

The maximum captured frequency that PWM can capture is confined by the capture interrupt latency. When capture interrupt occurred, software will do at least three steps, they are: Read PIIR to get interrupt source and Read CRLRx/CFLRx(x=0~3) to get capture value and finally write 1 to clear PIIR to zero. If interrupt latency will take time T0 to finish, the capture signal mustn't transition during this interval (T0). In this case, the maximum capture frequency will be 1/T0. For example:

HCLK = 50 MHz, PWM_CLK = 25 MHz, Interrupt latency is 900 ns

So the maximum capture frequency will is 1/900ns ≈ 1000 kHz

5.6.2 Features

5.6.2.1 PWM function features:

- PWM group has two PWM generators. Each PWM generator supports one 8-bit prescaler, one clock divider, two PWM-timers (down counter), one dead-zone generator and two PWM outputs.
- Up to 16-bit resolution
- PWM Interrupt request synchronized with PWM period
- One-shot or Auto-reload mode PWM
- Up to 2 PWM group (PWMA/PWMB) to support 8 PWM channels or 4 PWM paired channels (only 1 PWM group support for NuMicro™ NUC100/NUC120 Low Density)

5.6.2.2 Capture Function Features:

- Timing control logic shared with PWM Generators
- Support 8 Capture input channels shared with 8 PWM output channels (NuMicro™ NUC100/NUC120 Low Density only support 4 Capture input channels shared with 4 PWM output channels)
- Each channel supports one rising latch register (CRLR), one falling latch register (CFLR) and Capture interrupt flag (CAPIFx)

System clock = Internal 22.1184 MHz high speed oscillator						
Baud rate	Mode0		Mode1		Mode2	
	Parameter	Register	Parameter	Register	Parameter	Register
921600	x	x	A=0,B=11	0x2B00_0000	A=22	0x3000_0016
460800	A=1	0x0000_0001	A=1,B=15 A=2,B=11	0x2F00_0001 0x2B00_0002	A=46	0x3000_002E
230400	A=4	0x0000_0004	A=4,B=15 A=6,B=11	0x2F00_0004 0x2B00_0006	A=94	0x3000_005E
115200	A=10	0x0000_000A	A=10,B=15 A=14,B=11	0x2F00_000A 0x2B00_000E	A=190	0x3000_00BE
57600	A=22	0x0000_0016	A=22,B=15 A=30,B=11	0x2F00_0016 0x2B00_001E	A=382	0x3000_017E
38400	A=34	0x0000_0022	A=62,B=8 A=46,B=11 A=34,B=15	0x2800_003E 0x2B00_002E 0x2F00_0022	A=574	0x3000_023E
19200	A=70	0x0000_0046	A=126,B=8 A=94,B=11 A=70,B=15	0x2800_007E 0x2B00_005E 0x2F00_0046	A=1150	0x3000_047E
9600	A=142	0x0000_008E	A=254,B=8 A=190,B=11 A=142,B=15	0x2800_00FE 0x2B00_00BE 0x2F00_008E	A=2302	0x3000_08FE
4800	A=286	0x0000_011E	A=510,B=8 A=382,B=11 A=286,B=15	0x2800_01FE 0x2B00_017E 0x2F00_011E	A=4606	0x3000_11FE

Table 5-7 UART Baud Rate Setting Table

The UART0 and UART1 controllers support auto-flow control function that uses two low-level signals, /CTS (clear-to-send) and /RTS (request-to-send), to control the flow of data transfer between the UART and external devices (ex: Modem). When auto-flow is enabled, the UART is not allowed to receive data until the UART asserts /RTS to external device. When the number of bytes in the RX FIFO equals the value of RTS_TRI_LEV (UA_FCR [19:16]), the /RTS is de-asserted. The UART sends data out when UART controller detects /CTS is asserted from external device. If a valid asserted /CTS is not detected the UART controller will not send data out.

The UART controllers also provides Serial IrDA (SIR, Serial Infrared) function (User must set IrDA_EN (UA_FUN_SEL [1]) to enable IrDA function). The SIR specification defines a short-range infrared asynchronous serial transmission mode with one start bit, 8 data bits, and 1 stop bit. The maximum data rate is 115.2 Kbps (half duplex). The IrDA SIR block contains an IrDA SIR Protocol encoder/decoder. The IrDA SIR protocol is half-duplex only. So it cannot transmit and receive data at the same time. The IrDA SIR physical layer specifies a minimum 10ms transfer delay between transmission and reception. This delay feature must be implemented by software.

For NuMicro™ NUC100/NUC120 Low Density, another alternate function of UART controllers is RS-485 9-bit mode function, and direction control provided by RTS pin or can program GPIO (PB.2 for RTS0 and PB.6 for RTS1) to implement the function by software. The RS-485 mode is selected by setting the UA_FUN_SEL register to select RS-485 function. The RS-485 driver control is implemented using the RTS control signal from an asynchronous serial port to enable the RS-485 driver. In RS-485 mode, many characteristics of the RX and TX are same as UART.

7 ELECTRICAL CHARACTERISTICS

7.1 Absolute Maximum Ratings

SYMBOL	PARAMETER	MIN	MAX	UNIT
DC Power Supply	V_{DD}–V_{SS}	-0.3	+7.0	V
Input Voltage	V_{IN}	V_{SS}-0.3	V_{DD}+0.3	V
Oscillator Frequency	$1/t_{CLCL}$	4	24	MHz
Operating Temperature	TA	-40	+85	°C
Storage Temperature	TST	-55	+150	°C
Maximum Current into V_{DD}		-	120	mA
Maximum Current out of V_{SS}			120	mA
Maximum Current sunk by a I/O pin			35	mA
Maximum Current sourced by a I/O pin			35	mA
Maximum Current sunk by total I/O pins			100	mA
Maximum Current sourced by total I/O pins			100	mA

Note: Exposure to conditions beyond those listed under absolute maximum ratings may adversely affects the lift and reliability of the device.

PARAMETER	SYM.	SPECIFICATION				TEST CONDITIONS
		MIN.	TYP.	MAX.	UNIT	
Input High Voltage PA, PB, PC, PD, PE (Schmitt input)	V_{IH2}	0.4 V_{DD}	-	V_{DD}+0.5	V	
Hysteresis voltage of PA~PE (Schmitt input)	V_{HY}		0.2 V_{DD}		V	
Input Low Voltage XT1[*2]	V_{IL3}	0	-	0.8	V	V_{DD} = 4.5 V
		0	-	0.4		V_{DD} = 3.0 V
Input High Voltage XT1[*2]	V_{IH3}	3.5	-	V_{DD} +0.2	V	V_{DD} = 5.5 V
		2.4	-	V_{DD} +0.2		V_{DD} = 3.0 V
Input Low Voltage X32I[*2]	V_{IL4}	0	-	0.4	V	
Input High Voltage X32I[*2]	V_{IH4}	1.7		2.5	V	
Negative going threshold (Schmitt input), /RESET	V_{ILS}	-0.5	-	0.3 V_{DD}	V	
Positive going threshold (Schmitt input), /RESET	V_{IHS}	0.7 V_{DD}	-	V_{DD}+0.5	V	
Source Current PA, PB, PC, PD, PE (Quasi-bidirectional Mode)	I_{SR11}	-300	-370	-450	μA	V_{DD} = 4.5 V, V_S = 2.4 V
	I_{SR12}	-50	-70	-90	μA	V_{DD} = 2.7 V, V_S = 2.2 V
	I_{SR13}	-40	-60	-80	μA	V_{DD} = 2.5 V, V_S = 2.0 V
Source Current PA, PB, PC, PD, PE (Push-pull Mode)	I_{SR21}	-20	-24	-28	mA	V_{DD} = 4.5 V, V_S = 2.4 V
	I_{SR22}	-4	-6	-8	mA	V_{DD} = 2.7 V, V_S = 2.2 V
	I_{SR23}	-3	-5	-7	mA	V_{DD} = 2.5 V, V_S = 2.0 V
Sink Current PA, PB, PC, PD, PE (Quasi-bidirectional and Push-pull Mode)	I_{SK11}	10	16	20	mA	V_{DD} = 4.5 V, V_S = 0.45 V
	I_{SK12}	7	10	13	mA	V_{DD} = 2.7 V, V_S = 0.45 V
	I_{SK13}	6	9	12	mA	V_{DD} = 2.5 V, V_S = 0.45 V
Brown-Out voltage with BOV_VL [1:0] =00b	$V_{BO2.2}$	2.1	2.2	2.3	V	
Brown-Out voltage with BOV_VL [1:0] =01b	$V_{BO2.7}$	2.6	2.7	2.8	V	
Brown-Out voltage with BOV_VL [1:0] =10b	$V_{BO3.8}$	3.6	3.8	4.0	V	
Brown-Out voltage with BOV_VL [1:0] =11b	$V_{BO4.5}$	4.3	4.5	4.7	V	
Hysteresis range of BOD voltage	V_{BH}	30	-	150	mV	V_{DD} = 2.5 V~5.5 V

7.2.2 NuMicro™ NUC100/NUC120 Low Density DC Electrical Characteristics

(V_{DD}-V_{SS}=3.3 V, TA = 25°C, FOSC = 50 MHz unless otherwise specified.)

PARAMETER	SYM.	SPECIFICATION				TEST CONDITIONS
		MIN.	TYP.	MAX.	UNIT	
Operation voltage	V_{DD}	2.5		5.5	V	V_{DD} =2.5 V ~ 5.5 V up to 50 MHz
Power Ground	V_{SS} AV_{SS}	-0.3			V	
LDO Output Voltage	V_{LDO}	-10%	2.5	+10%	V	V_{DD} > 2.7 V
Analog Operating Voltage	AV_{DD}	0		V_{DD}	V	
Analog Reference Voltage	Vref	0		AV_{DD}	V	
Operating Current Normal Run Mode @ 50 MHz	I_{DD1}		46		mA	V_{DD} = 5.5 V@50 MHz, enable all IP and PLL, XTAL=12 MHz
	I_{DD2}		30		mA	V_{DD} = 5.5 V@50 MHz, disable all IP and enable PLL, XTAL=12 MHz
	I_{DD3}		44		mA	V_{DD} = 3 V@50 MHz, enable all IP and PLL, XTAL=12 MHz
	I_{DD4}		28		mA	V_{DD} = 3 V@50 MHz, disable all IP and enable PLL, XTAL=12 MHz
Operating Current Normal Run Mode @ 12 MHz	I_{DD5}		19		mA	V_{DD} = 5.5 V@12 MHz, enable all IP and disable PLL, XTAL=12 MHz
	I_{DD6}		13		mA	V_{DD} = 5.5 V@12 MHz, disable all IP and disable PLL, XTAL=12 MHz
	I_{DD7}		17		mA	V_{DD} = 3 V@12 MHz, enable all IP and disable PLL, XTAL=12 MHz

PARAMETER	SYM.	SPECIFICATION				TEST CONDITIONS
		MIN.	TYP.	MAX.	UNIT	
Input High Voltage PA, PB, PC, PD, PE (Schmitt input)	V_{IH2}	0.4 V_{DD}	-	V_{DD} +0.5	V	
Hysteresis voltage of PA~PE (Schmitt input)	V_{HY}		0.2 V_{DD}		V	
Input Low Voltage XT1[*2]	V_{IL3}	0	-	0.8	V	V_{DD} = 4.5 V
		0	-	0.4		V_{DD} = 3.0 V
Input High Voltage XT1[*2]	V_{IH3}	3.5	-	V_{DD} +0.2	V	V_{DD} = 5.5 V
		2.4	-	V_{DD} +0.2		V_{DD} = 3.0 V
Input Low Voltage X32I[*2]	V_{IL4}	0	-	0.4	v	
Input High Voltage X32I[*2]	V_{IH4}	1.7		2.5	V	
Negative going threshold (Schmitt input), /RESET	V_{ILS}	-0.5	-	0.3 V_{DD}	V	
Positive going threshold (Schmitt input), /RESET	V_{IHS}	0.7 V_{DD}	-	V_{DD}+0.5	V	
Source Current PA, PB, PC, PD, PE (Quasi-bidirectional Mode)	I_{SR11}	-300	-370	-450	µA	V_{DD} = 4.5 V, V_S = 2.4 V
	I_{SR12}	-50	-70	-90	µA	V_{DD} = 2.7 V, V_S = 2.2 V
	I_{SR12}	-40	-60	-80	µA	V_{DD} = 2.5 V, V_S = 2.0 V
Source Current PA, PB, PC, PD, PE (Push-pull Mode)	I_{SR21}	-20	-24	-28	mA	V_{DD} = 4.5 V, V_S = 2.4 V
	I_{SR22}	-4	-6	-8	mA	V_{DD} = 2.7 V, V_S = 2.2 V
	I_{SR22}	-3	-5	-7	mA	V_{DD} = 2.5 V, V_S = 2.0 V
Sink Current PA, PB, PC, PD, PE (Quasi-bidirectional and Push-pull Mode)	I_{SK1}	10	16	20	mA	V_{DD} = 4.5 V, V_S = 0.45 V
	I_{SK1}	7	10	13	mA	V_{DD} = 2.7 V, V_S = 0.45 V
	I_{SK1}	6	9	12	mA	V_{DD} = 2.5 V, V_S = 0.45 V
Brown-Out voltage with BOV_VL [1:0] =00b	$V_{BO2.2}$	2.1	2.2	2.3	V	
Brown-Out voltage with BOV_VL [1:0] =01b	$V_{BO2.7}$	2.6	2.7	2.8	V	
Brown-Out voltage with BOV_VL [1:0] =10b	$V_{BO3.8}$	3.6	3.8	4.0	V	
Brown-Out voltage with BOV_VL [1:0] =11b	$V_{BO4.5}$	4.3	4.5	4.7	V	
Hysteresis range of BOD voltage	V_{BH}	30	-	150	mV	V_{DD} = 2.5 V~5.5 V

7.4 Analog Characteristics

7.4.1 Specification of 12-bit SARADC

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT
-	Resolution	-	-	12	Bit
DNL	Differential nonlinearity error	-	±3	-	LSB
INL	Integral nonlinearity error	-	±4	-	LSB
EO	Offset error	-	±1	10	LSB
EG	Gain error (Transfer gain)	-	1	1.005	-
-	Monotonic	Guaranteed			
FADC	ADC clock frequency (AV_{DD}=5V/3V)	-	-	16/8	MHz
FS	Sample rate	-	-	600	K SPS
V_{DDA}	Supply voltage	3	-	5.5	V
I_{DD}	Supply current (Avg.)	-	0.5	-	mA
I_{DDA}		-	1.5	-	mA
V_{REF}	Reference voltage	-	V_{DDA}	-	V
I_{REF}	Reference current (Avg.)	-	1	-	mA
V_{IN}	Input voltage	0	-	V_{REF}	V

7.4.3 Specification of Low Voltage Reset

PARAMETER	CONDITION	MIN.	TYP.	MAX.	UNIT
Operation voltage	-	1.7	-	5.5	V
Quiescent current	V_{DD}=5.5 V	-	-	5	uA
Temperature	-	-40	25	85	℃
Threshold voltage	Temperature=25℃	1.7	2.0	2.3	V
	Temperature=-40℃	-	2.4	-	V
	Temperature=85℃	-	1.6	-	V
Hysteresis	-	0	0	0	V

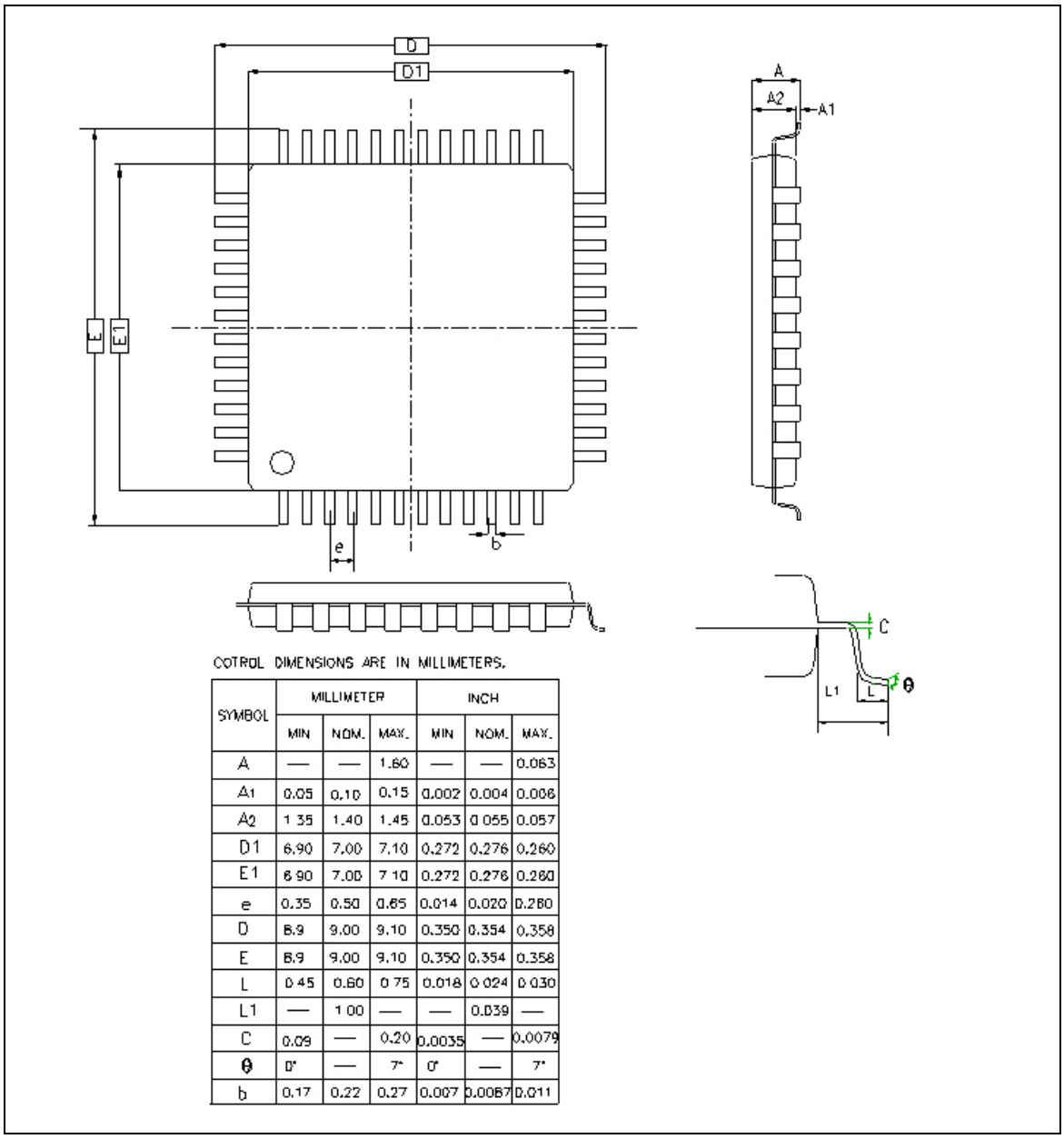
7.4.4 Specification of Brown-Out Detector

PARAMETER	CONDITION	MIN.	TYP.	MAX.	UNIT
Operation voltage	-	2.5	-	5.5	V
Quiescent current	AV_{DD}=5.5 V	-	-	125	μA
Temperature	-	-40	25	85	℃
Brown-Out voltage	BOV_VL[1:0]=11	4.3	4.5	4.7	V
	BOV_VL [1:0]=10	3.6	3.8	4.0	V
	BOV_VL [1:0]=01	2.6	2.7	2.8	V
	BOV_VL [1:0]=00	2.1	2.2	2.3	V
Hysteresis	-	30	-	150	mV

7.4.5 Specification of Power-On Reset (5 V)

PARAMETER	CONDITION	MIN.	TYP.	MAX.	UNIT
Temperature	-	-40	25	85	℃
Reset voltage	V+	-	2	-	V
Quiescent current	Vin>reset voltage	-	1	-	nA

8.3 48L LQFP (7x7x1.4mm footprint 2.0mm)



CONTROL DIMENSIONS ARE IN MILLIMETERS.

SYMBOL	MILLIMETER			INCH		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	—	—	1.60	—	—	0.063
A1	0.05	0.10	0.15	0.002	0.004	0.006
A2	1.35	1.40	1.45	0.053	0.055	0.057
D1	6.90	7.00	7.10	0.272	0.276	0.280
E1	6.90	7.00	7.10	0.272	0.276	0.280
e	0.35	0.50	0.65	0.014	0.020	0.280
D	8.9	9.00	9.10	0.350	0.354	0.358
E	8.9	9.00	9.10	0.350	0.354	0.358
L	0.45	0.60	0.75	0.018	0.024	0.030
L1	—	1.00	—	—	0.039	—
C	0.09	—	0.20	0.0035	—	0.0079
θ	0°	—	7°	0°	—	7°
b	0.17	0.22	0.27	0.007	0.0087	0.011